

Search Notes



Application/Control No.

10/673,041

Examiner

Tae H. Yoon

Applicant(s)/Patent under Reexamination

SOHIER ET AL.

Art Unit

1714

SEARCHED

Class	Subclass	Date	Examiner
524	17	9-15-04	21
524	601		
424	426		
427	2.1		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST Inventor Search	9-6-05	21